Spring-loaded test probe **GKS-004 308 396 A 2000** Item GKS-004-0020





- Robust, compact design for harsh ICT/FCT applications with limited space
- For optimum contact at the test points (e.g. pads, vias, and pins), various tip styles in different diameters and finishes, as well as various spring forces are available. spring forces.

General data

Product group ICT / FCT (in-circuit test and function test Sub-product group Short/robust GKS GKS-004 Series Grid 4.75 mm [187 mil] Contacting from Pad, Via, Female connector Magnetic Yes Installation type Plug-in Quick-exchange system Yes Adjustable installation height No Non-rotating No Compatible receptacle(s) KS-004 Min. temperature - 40 °C [- 104 °F] Max. temperature + 80 °C [+ 176 °F] RoHS-compliant RoHS-3;6c



Current load capacity / rated current 8 A
Typical resistance (Ri) <20 mOhm



 Total length
 33.6 mm [1.32 in]

 Barrel diameter
 2.36 mm [.092 in]

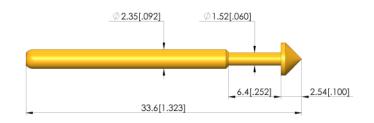
 Maximum stroke
 6.35 mm [.25 in]

 Spring pre-load
 1.02 N [3.66 ozf]

 Collar height
 00

 Spring force at working stroke
 2 N [7.19 ozf]

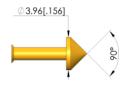
 Recommended working stroke
 4.4 mm [.173 in]



Tip style data

Tip style 08 90°conical, self-cleaning
Tip diameter 3.96 mm [.155 in]
Tip style surface A gold
Tip style material 3 CuBe

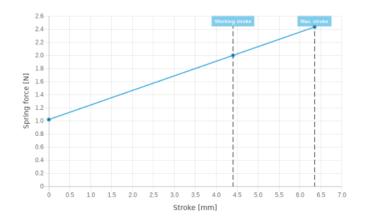




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Learn more about ICT/FCT Test probes

